

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/697,121	VAN ACKERE E	T AL.	
Examiner	Art Unit		
Quang N. Nguyen	2441		

SEARCHED					
Class	Subclass	Date	Examiner		
370	389	9/13/2007	QN		
709	227	9/13/2007	QN		
709	237	9/13/2007	QN		
709	238	9/13/2007	QN		
709	239	9/13/2007	QN		
709	240	9/13/2007	QN		
709	242	9/13/2007	QN		
709	243	9/13/2007	QN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
709	218	5/29/2009	QN		
709	224	5/29/2009	QN		
709	238	5/29/2009	QN		
709/239,242		5/29/2009	QN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Name Search	9/11/2007	QN		
East Search (see notes)	9/11/2007	QN		
East Search (see notes)	9/13/2007	QN		
East Search (see notes)	5/29/2009	QN		
IEEE Search (see notes)	5/29/2009	QN		
Google Search (see notes)	5/29/2009	QN		